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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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600V, 42A, 0.11Ω Max t_{rr} ≤290ns

N-Channel FREDFET

Power MOS 8^{TM} is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced t_{rr} , soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of $C_{\text{rss}}/C_{\text{iss}}$ result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



Single die FREDFET

FEATURES

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C_{rss} for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant

TYPICAL APPLICATIONS

- · ZVS phase shifted and other full bridge
- · Half bridge
- · PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
	Continuous Drain Current @ T _C = 25°C	42	
'D	Continuous Drain Current @ T _C = 100°C	26	Α
I _{DM}	Pulsed Drain Current ^①	210	
V_{GS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy ©	1580	mJ
I _{AR}	Avalanche Current, Repetitive or Non-Repetitive	28	Α

Thermal and Mechanical Characteristics

Symbol	Characteristic		Тур	Max	Unit
P _D	Total Power Dissipation @ T _C = 25°C			480	W
R _{0JC}	Junction to Case Thermal Resistance			0.26	°C/W
R _{ecs}	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15		C/VV
T_J , T_{STG}	Operating and Storage Junction Temperature Range			150	°C
V _{Isolation}	RMS Voltage (50-60hHz Sinusoidal Waveform from Terminals to Mounting Base for 1 Min.)	2500			V
W _T	Dackage Weight		1.03		OZ
''T	Package Weight		29.2		g
Torque	Terminals and Mounting Screws.			10	in·lbf
				1.1	N·m

T_J = 25°C unless otherwise specified

APT39F60J

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
V _{BR(DSS)}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250\mu A$		600			V
$\Delta V_{BR(DSS)} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, $I_D = 250\mu A$			0.57		V/°C
R _{DS(on)}	Drain-Source On Resistance [®]	V _{GS} = 10V, I _D = 28A			0.09	0.11	Ω
V _{GS(th)}	Gate-Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 2.5$ mA		2.5	4	5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Threshold Voltage Temperature Coefficient				-10		mV/°C
	Zero Gate Voltage Drain Current	V _{DS} = 600V	T _J = 25°C			250	μA
DSS	Zero Gate voltage Drain Current	V _{GS} = 0V	T _J = 125°C			1000] μΑ
I _{GSS}	Gate-Source Leakage Current	V _{GS} = ±30V				±100	nA

Dynamic Characteristics

T₁ = 25°C unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
g _{fs}	Forward Transconductance	V _{DS} = 50V, I _D = 28A		55		S
C _{iss}	Input Capacitance	V 0V V 05V		11300		
C _{rss}	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ f = 1MHz		115		
C _{oss}	Output Capacitance	1 11112		1040		
$C_{o(cr)}$ $\textcircled{4}$	Effective Output Capacitance, Charge Related	V = 0V V = 0V to 400V		550		pF
C _{o(er)} ⑤	Effective Output Capacitance, Energy Related	V _{GS} = 0V, V _{DS} = 0V to 400V		285		
Q _g	Total Gate Charge	\\ -0 to 40\\ 1 - 20 A		280		
Q_{gs}	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 28A,$ $V_{DS} = 300V$		60		nC
Q_{gd}	Gate-Drain Charge	V _{DS} = 300V		120		
t _{d(on)}	Turn-On Delay Time	Resistive Switching		65		
t _r	Current Rise Time	V _{DD} = 400V, I _D = 28A		75		ns
t _{d(off)}	Turn-Off Delay Time	$R_{G} = 2.2\Omega^{\textcircled{6}}, V_{GG} = 15V$		190		115
t _f	Current Fall Time			60		

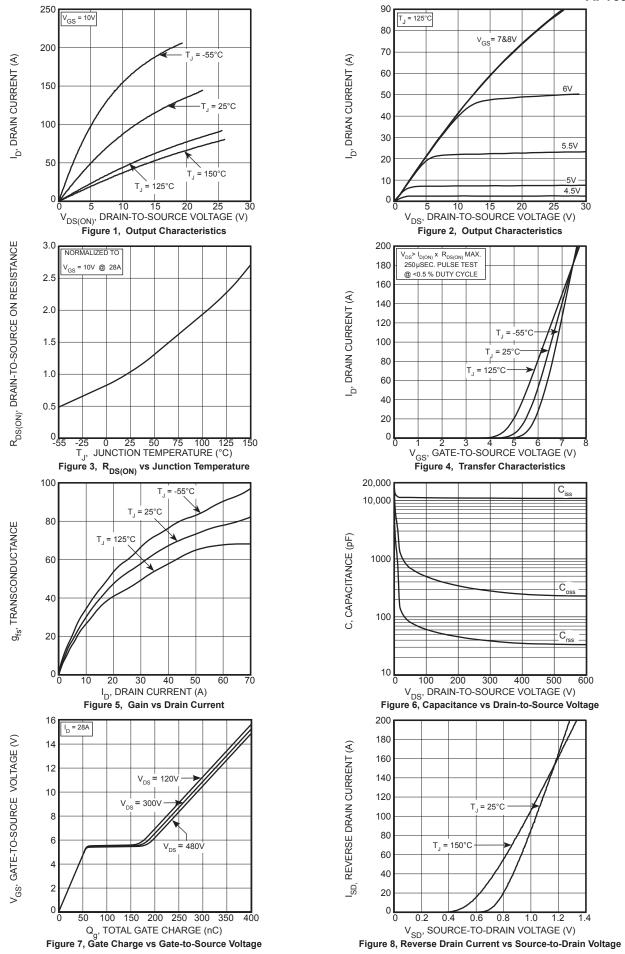
Source-Drain Diode Characteristics

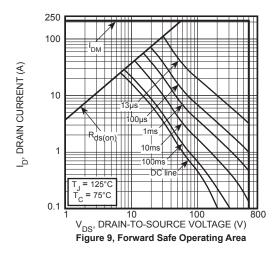
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
I _s	Continuous Source Current (Body Diode)	MOSFET symbol showing the interest species of the state o			42	А
I _{SM}	Pulsed Source Current (Body Diode) ^①	integral reverse p-n junction diode (body diode)			210	
V _{SD}	Diode Forward Voltage	I _{SD} = 28A, T _J = 25°C, V _{GS} = 0V			1.2	V
t _{rr}	Doverse December Time	T _J = 25°C		255	290	no
rr	Reverse Recovery Time	T _J = 125°C		450	540	ns
Q _{rr}	Davaraa Daaayary Charga	$I_{SD} = 28A^{\circ}$ $T_{J} = 25^{\circ}C$		1.41		u.C
G _{rr}	Reverse Recovery Charge	$di_{SD}/dt = 100A/\mu s$ $T_{J} = 125^{\circ}C$		3.66		μC
1	Devenue Deservent Comment	$V_{DD} = 100V$ $T_{J} = 25^{\circ}C$		10.7		Α
'rrm	Reverse Recovery Current	T _J = 125°C		15.8] ^
dv/dt	Peak Recovery dv/dt	I _{SD} ≤ 28A, di/dt ≤1000A/µs, V _{DD} = 400V, T _J = 125°C			20	V/ns

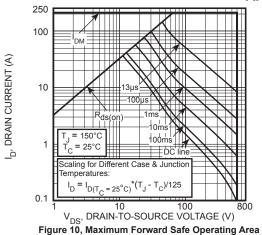
- 1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- ② Starting at $T_J = 25^{\circ}C$, L = 4.03mH, $R_G = 25\Omega$, $I_{AS} = 28A$.
- (3) Pulse test: Pulse Width < 380µs, duty cycle < 2%.

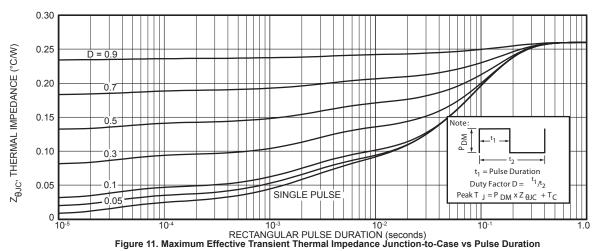
- \bigcirc R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.









SOT-227 (ISOTOP®) Package Outline

